HALOGEN

**FREE** 

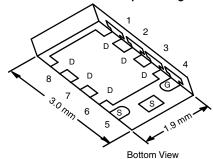




# N-Channel 20 V (D-S) MOSFET

| PRODUC              | CT SUMMARY                           |                                 |                       |
|---------------------|--------------------------------------|---------------------------------|-----------------------|
| V <sub>DS</sub> (V) | $R_{DS(on)}\left(\Omega\right)$ Max. | I <sub>D</sub> (A) <sup>a</sup> | Q <sub>g</sub> (Typ.) |
|                     | 0.0100 at V <sub>GS</sub> = 4.5 V    | 25                              |                       |
| 20                  | 0.0115 at V <sub>GS</sub> = 2.5 V    | 25                              | 16.6 nC               |
|                     | 0.0135 at V <sub>GS</sub> = 1.8 V    | 25                              |                       |

## **PowerPAK ChipFET Single**



## Ordering Information:

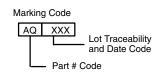
Si5442DU-T1-GE3 (Lead (Pb)-free and Halogen-free)

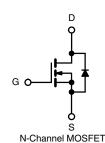
## **FEATURES**

- TrenchFET® Power MOSFET
- Thermally Enhanced PowerPAK® ChipFET® Package
  - Small Footprint Area
  - Low On-Resistance
  - Thin 0.8 mm Profile
- 100% R<sub>a</sub> Tested
- Material categorization: For definitions of compliance please see www.vishay.com/doc?99912

## **APPLICATIONS**

- Load Switch, PA Switch, and for Portable Applications
- Point-of-Load
- DC/DC Converters
- **Power Management**





| ABSOLUTE MAXIMUM RATIN                              | IGS (T <sub>A</sub> = 25 °C   | , unless othe   | erwise noted)        |      |
|---|---|-----------------|----------------------|------|
| Parameter   |   | Symbol          | Limit                | Unit |
| Drain-Source Voltage                                |   | V <sub>DS</sub> | 20                   | V    |
| Gate-Source Voltage                                 |   | V <sub>GS</sub> | ± 8                  | - V  |
|   | T <sub>C</sub> = 25 °C  |                 | 25 <sup>a</sup>      |      |
| Continuous Drain Current (T <sub>.1</sub> = 150 °C) | T <sub>C</sub> = 70 °C  | ] . [           | 25 <sup>a</sup>      |      |
| Continuous Diain Current (1) = 130 C)               | T <sub>A</sub> = 25 °C  | I <sub>D</sub>  | 12.4 <sup>b, c</sup> |      |
|   | T <sub>A</sub> = 70 °C  | 1               | 9.9 <sup>b, c</sup>  | Α    |
| Pulsed Drain Current (t = 300 μs)                   | •   | I <sub>DM</sub> | 60                   |      |
| Continuous Source-Drain Diode Current               | T <sub>C</sub> = 25 °C  |                 | 25 <sup>a</sup>      |      |
| Continuous Source-Diam Diode Current                | T <sub>A</sub> = 25 °C  | ls l            | 2.6 <sup>b, c</sup>  |      |
|   | T <sub>C</sub> = 25 °C  |                 | 31                   |      |
| Maximum Power Dissipation                           | T <sub>C</sub> = 70 °C  | P <sub>D</sub>  | 20                   | w    |
| Maximum Power Dissipation                           | T <sub>A</sub> = 25 °C  | ] 'D            | 3.1 <sup>b, c</sup>  | 7 vv |
|   | T <sub>A</sub> = 70 °C  | 1               | 2 <sup>b, c</sup>    |      |
| Operating Junction and Storage Temperatur           | ction and Storage Temperature Range T <sub>J</sub> , T <sub>stg</sub> - 55 to 150 |                 | °C                   |      |
| Soldering Recommendations (Peak Temper              | ature) <sup>d, e</sup>  |                 | 260                  | 7    |

| THERMAL RESISTANCE RATINGS                  |              |                   |         |         |       |
|---|--------------|-------------------|---------|---------|-------|
| Parameter                                   |              | Symbol            | Typical | Maximum | Unit  |
| Maximum Junction-to-Ambient <sup>b, f</sup> | t ≤ 5 s      | R <sub>thJA</sub> | 34      | 40      | °C/W  |
| Maximum Junction-to-Case (Drain)            | Steady State | R <sub>thJC</sub> | 3       | 4       | O/ VV |

### Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- d. See solder profile (www.vishay.com/doc273257). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 90 °C/W.

Document Number: 63233 S13-2149-Rev. B, 14-Oct-13

# **Si5442DU**

# Vishay Siliconix



| <b>SPECIFICATIONS</b> $(T_J = 25  ^{\circ}\text{C})$ | , uniess oth            |  |      |        |          |  |
|--|-------------------------|--|------|--------|----------|--|
| Parameter  | Symbol                  | Test Conditions  | Min. | Тур.   | Max.     | Unit   |
| Static   |                         |  |      |        |          |  |
| Drain-Source Breakdown Voltage                       | $V_{DS}$                | $V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$   | 20   |        |          | V  |
| V <sub>DS</sub> Temperature Coefficient              | $\Delta V_{DS}/T_{J}$   | I <sub>D</sub> = 250 μA  |      | 21     |          | mV/°C  |
| V <sub>GS(th)</sub> Temperature Coefficient          | $\Delta V_{GS(th)}/T_J$ | η – 200 μΛ   |      | - 3    |          |  |
| Gate-Source Threshold Voltage                        | V <sub>GS(th)</sub>     | $V_{DS} = V_{GS}$ , $I_D = 250 \mu A$  | 0.4  |        | 0.9      | V  |
| Gate-Source Leakage                                  | I <sub>GSS</sub>        | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$   |      |        | ± 100    | nA   |
| Zara Cata Valtaga Drain Current                      |                         | V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V  |      |        | 1        | μΑ   |
| Zero Gate Voltage Drain Current                      | I <sub>DSS</sub>        | $V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$                 |      |        | 10       |  |
| On-State Drain Current <sup>a</sup>                  | I <sub>D(on)</sub>      | $V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$   | 20   |        |          | Α  |
|  |                         | $V_{GS} = 4.5 \text{ V}, I_D = 8 \text{ A}$  |      | 0.0080 | 0.0100   |  |
| Drain-Source On-State Resistance <sup>a</sup>        | R <sub>DS(on)</sub>     | $V_{GS} = 2.5 \text{ V}, I_D = 7 \text{ A}$  |      | 0.0090 | 0.0115   | Ω  |
|  |                         | $V_{GS} = 1.8 \text{ V}, I_D = 4 \text{ A}$  |      | 0.0100 | 0.0135   |  |
| Forward Transconductance <sup>a</sup>                | 9 <sub>fs</sub>         | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 8 A   |      | 65     |          | S  |
| Dynamic <sup>b</sup>                                 |                         |  |      | I.     | <u> </u> |  |
| Input Capacitance                                    | C <sub>iss</sub>        |  |      | 1700   |          |  |
| Output Capacitance                                   | C <sub>oss</sub>        | $V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$                           |      | 280    |          | рF   |
| Reverse Transfer Capacitance                         | C <sub>rss</sub>        | 35   |      | 115    |          | '  |
| ·  | 100                     | V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 8 V, I <sub>D</sub> = 15 A                       |      | 29     | 45       | <del>                                     </del> |
| Total Gate Charge                                    | $Q_g$                   | 20 40 2  |      | 16.6   | 25       | _  |
| Gate-Source Charge                                   | Q <sub>gs</sub>         | $V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 15 \text{ A}$                        |      | 1.9    |          | nC   |
| Gate-Drain Charge                                    | Q <sub>gd</sub>         | - DS   |      | 2      |          |  |
| Gate Resistance                                      | R <sub>g</sub>          | f = 1 MHz  | 0.28 | 1.4    | 2.8      | Ω  |
| Turn-on Delay Time                                   | t <sub>d(on)</sub>      |  |      | 10     | 20       |  |
| Rise Time  | t <sub>r</sub>          | $V_{DD}$ = 10 V, $R_L$ = 1 $\Omega$  |      | 15     | 30       |  |
| Turn-Off Delay Time                                  | t <sub>d(off)</sub>     | $I_D\cong$ 10 A, $V_{GEN}$ = 4.5 V, $R_g$ = 1 $\Omega$                                     |      | 35     | 70       | 1  |
| Fall Time  | t <sub>f</sub>          |  |      | 10     | 20       |  |
| Turn-On Delay Time                                   | t <sub>d(on)</sub>      |  |      | 10     | 20       | ns   |
| Rise Time  | t <sub>r</sub>          | $V_{DD}$ = 10 V, $R_L$ = 1 $\Omega$  |      | 10     | 20       |  |
| Turn-Off Delay Time                                  | t <sub>d(off)</sub>     | $I_D\cong$ 10 A, $V_{GEN}$ = 8 V, $R_g$ = 1 $\Omega$                                       |      | 30     | 60       |  |
| Fall Time  | t <sub>f</sub>          |  |      | 10     | 20       | 1  |
| Drain-Source Body Diode Characteristi                |                         |  |      |        |          |  |
| Continuous Source-Drain Diode Current                | I <sub>S</sub>          | T <sub>C</sub> = 25 °C   |      |        | 25       |  |
| Pulse Diode Forward Current                          | I <sub>SM</sub>         | -  |      |        | 60       | Α  |
| Body Diode Voltage                                   | V <sub>SD</sub>         | I <sub>S</sub> = 10 A, V <sub>GS</sub> = 0 V   |      | 0.8    | 1.2      | V  |
| Body Diode Reverse Recovery Time                     | t <sub>rr</sub>         |  |      | 20     | 40       | ns   |
| Body Diode Reverse Recovery Charge                   | Q <sub>rr</sub>         |  |      | 10     | 20       | nC   |
| Reverse Recovery Fall Time                           | t <sub>a</sub>          | $I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$ |      | 11     |          |  |
| Reverse Recovery Rise Time                           | t <sub>b</sub>          |  |      | 9      |          | ns   |

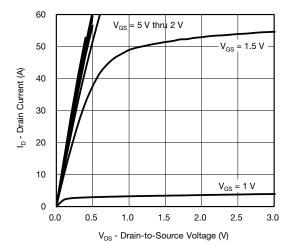
## Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

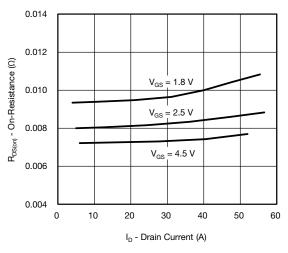
a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 % b. Guaranteed by design, not subject to production testing.



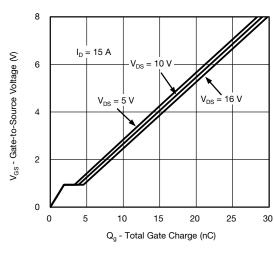
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



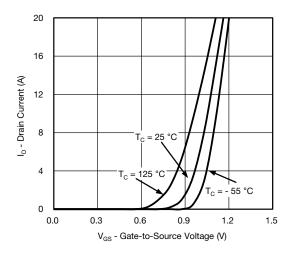
## **Output Characteristics**



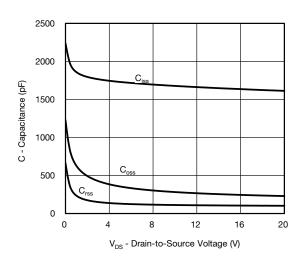
## On-Resistance vs. Drain Current and Gate Voltage



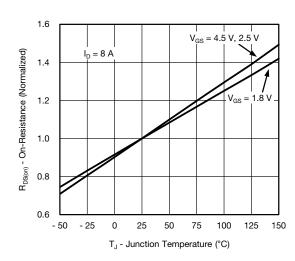
**Gate Charge** 



## **Transfer Characteristics**



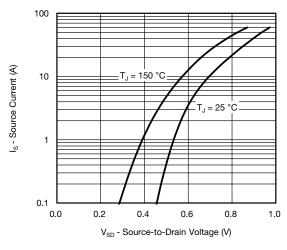
## Capacitance

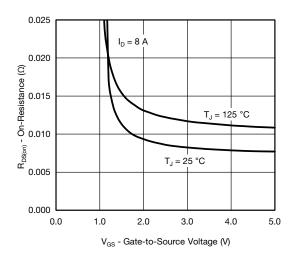


On-Resistance vs. Junction Temperature

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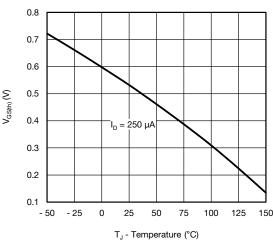
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

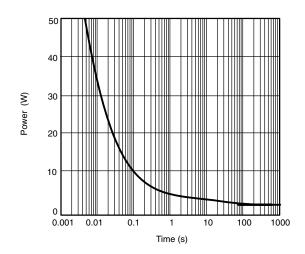




## Source-Drain Diode Forward Voltage

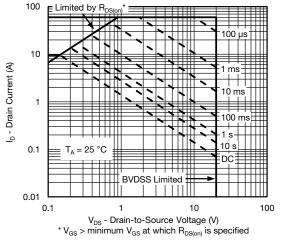






Threshold Voltage

Single Pulse Power, Junction-to-Ambient



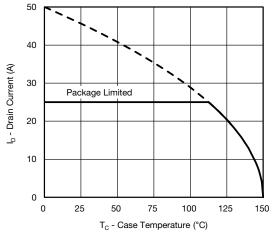
Safe Operating Area, Junction-to-Ambient

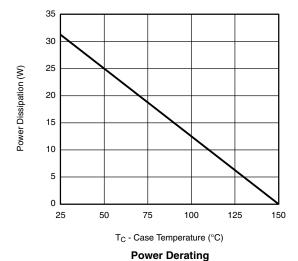






## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





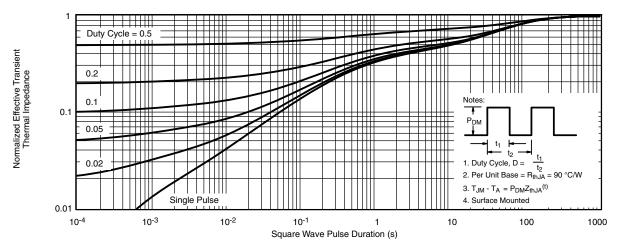
**Current Derating\*** 

 $<sup>^*</sup>$  The power dissipation  $P_D$  is based on  $T_{J(max.)}$  = 150  $^{\circ}$ C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

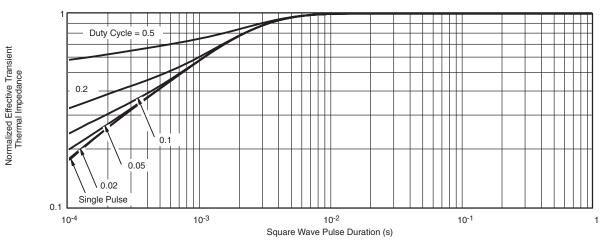
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## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient

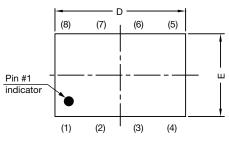


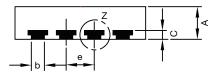
Normalized Thermal Transient Impedance, Junction-to-Case

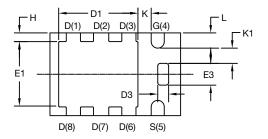
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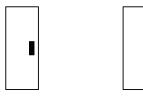
# PowerPAK® ChipFET® Case Outline







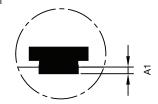
Backside view of single pad



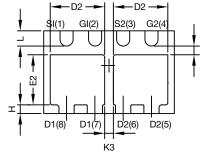
Side view of single



Side view of dual



Detail Z



Backside view of dual pad

| DIM. | MILLIMETERS |          |      | INCHES    |       |       |  |
|------|-------------|----------|------|-----------|-------|-------|--|
|      | MIN.        | NOM.     | MAX. | MIN.      | NOM.  | MAX.  |  |
| Α    | 0.70        | 0.75     | 0.85 | 0.028     | 0.030 | 0.033 |  |
| A1   | 0           | -        | 0.05 | 0         | -     | 0.002 |  |
| b    | 0.25        | 0.30     | 0.35 | 0.010     | 0.012 | 0.014 |  |
| С    | 0.15        | 0.20     | 0.25 | 0.006     | 0.008 | 0.010 |  |
| D    | 2.92        | 3.00     | 3.08 | 0.115     | 0.118 | 0.121 |  |
| D1   | 1.75        | 1.87     | 2.00 | 0.069     | 0.074 | 0.079 |  |
| D2   | 1.07        | 1.20     | 1.32 | 0.042     | 0.047 | 0.052 |  |
| D3   | 0.20        | 0.25     | 0.30 | 0.008     | 0.010 | 0.012 |  |
| Е    | 1.82        | 1.90     | 1.98 | 0.072     | 0.075 | 0.078 |  |
| E1   | 1.38        | 1.50     | 1.63 | 0.054     | 0.059 | 0.064 |  |
| E2   | 0.92        | 1.05     | 1.17 | 0.036     | 0.041 | 0.046 |  |
| E3   | 0.45        | 0.50     | 0.55 | 0.018     | 0.020 | 0.022 |  |
| е    |             | 0.65 BSC |      | 0.026 BSC |       |       |  |
| Н    | 0.15        | 0.20     | 0.25 | 0.006     | 0.008 | 0.010 |  |
| K    | 0.25        | -        | -    | 0.010     | -     | -     |  |
| K1   | 0.30        | -        | -    | 0.012     | -     | -     |  |
| K2   | 0.20        | -        | =    | 0.008     | -     | -     |  |
| K3   | 0.20        | -        | -    | 0.008     | -     | -     |  |
| L    | 0.30        | 0.35     | 0.40 | 0.012     | 0.014 | 0.016 |  |

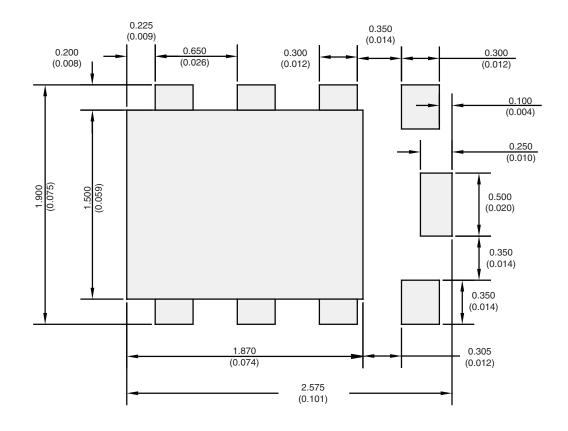
## C14-0630-Rev. E, 21-Jul-14 DWG: 5940

Note

• Millimeters will govern



## RECOMMENDED MINIMUM PADS FOR PowerPAK® ChipFET® Single



Recommended Minimum Pads Dimensions in mm/(Inches)

Return to Index

APPLICATION NOTE



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